Amendments to the Claims:

- 1. (currently amended) A method of estimating modulation noise for use testing an oscillator in a transmitter having within a phase locked loop, said method comprising the steps of:
 - averaging phase error samples produced by said phase locked loop, wherein said phase error samples correspond to the phase noise of said oscillator;
 - subtracting said average from a current phase error sample to yield a normalized phase error;
 - generating an exception event if said normalized phase error exceeds a threshold, thereby indicating that the level of oscillator phase noise is not acceptable; and
 - repeating said steps of averaging, subtracting and generating over a period of time and outputting a <u>test</u> failure indication if the number of exception events exceeds a maximum <u>criteria criterion</u> and a <u>test</u> pass indication otherwise.
- 2. (previously amended) The method according to claim 1, wherein said step of averaging comprises the step of calculating a moving average over a plurality of phase error samples.
- 3. (original) The method according to claim 1, wherein said threshold is configurable.
- 4. (currently amended) The method according to claim 1, wherein said maximum failure eriteria criterion is configurable.
- 5. (currently amended) The method according to claim 1, wherein said period of time is configurable and corresponds to the number of symbols to be considered in estimating said modulation phase noise.

- 6. (previously amended) The method according to claim 1, further comprising the step of decimating said phase error samples before said step of averaging.
- 7. (currently amended) The method according to claim 1, adapted to be implemented in testing software residing in an integrated on-chip processor such that the thereby eliminating the need for external software/hardware is substantially eliminated software and hardware to implement said method.
- 8. (original) The method according to claim 1, wherein said phase error samples comprise filtered phase error samples.
- 9. (currently amended) The method according to claim 1, wherein said transmitter is phase locked loop is used as the local oscillator for a transceiver compliant with a Bluetooth standard.
- 10. (currently amended) The method according to claim 1, wherein said transmitter phase locked loop is used in a transceiver within a wireless communications network.
- 11. (original) The method according to claim 1, wherein the phase locked loop comprises a digital phase locked loop.
- 12. (currently amended) The method according to claim 1, adapted to be implemented in an Application Specific Integrated Circuit (ASIC).
- 13. (currently amended) The method according to claim 1, adapted to be implemented in a Field Programmable Gate Array (FPGA).
- 14. (currently amended) An apparatus for estimating modulation noise for use testing an oscillator in a transmitter phase locked loop having a phase locked loop, comprising:

means for averaging phase error samples produced by said phase locked loop;

- means for subtracting said average from a current phase error sample to yield a normalized phase error, wherein said normalized phase error corresponds to the phase modulation noise of said oscillator;
- means for generating an exception event if said normalized phase error exceeds a threshold; and
- means for repeating said functions of averaging, subtracting and generating over a period of time and outputting a <u>test</u> failure indication if the number of exception events exceeds a maximum <u>criteria criterion</u> and a <u>test</u> pass indication otherwise.
- 15. (currently amended) The apparatus according to claim 14, wherein said mean means for averaging comprises means for calculating a moving average over a plurality of phase error samples.
- 16. (original) The apparatus according to claim 14, wherein said threshold is configurable.
- 17. (currently amended) The apparatus according to claim 14, wherein said maximum failure eriteria criterion is configurable.
- 18. (currently amended) The apparatus according to claim 14, wherein said period of time is configurable and corresponds to the number of symbols to be considered in estimating said modulation noise.
- 19. (original) The apparatus according to claim 14, further comprising means for decimating said phase error samples before said average is calculated.

- 20. (currently amended) The apparatus according to claim 14, adapted to be implemented in testing software adapted to execute on an on-chip software based processor.
- 21. (original) The apparatus according to claim 20, wherein said testing software is stored in rewritable memory wherein said testing software is replaced by normal operation software once testing is complete.
- 22. (currently amended) The apparatus according to claim 14, adapted to be implemented in an Application Specific Integrated Circuit (ASIC).
- 23. (currently amended) The apparatus according to claim 14, adapted to be implemented in a Field Programmable Gate Array (FPGA).
- 24. (currently amended) An apparatus for estimating modulation noise testing an oscillator in a transmitter phase locked loop, comprising:
 - first means for estimating frequency deviation errors of a signal output from said transmitter utilizing measurements of a phase error signal observed within a phase locked loop in said transmitter;
 - first means for measuring a phase error signal within said phase locked loop, wherein said phase error signal corresponds to the phase noise of said oscillator;
 - second means for comparing a plurality of phase error signal samples over a period of time to a threshold and generating an exception event each time a phase error signal sample exceeds said threshold; and
 - generating a <u>test</u> failure indication if the number of exception events exceeds a <u>criteria</u> <u>defined limit</u> and generating a <u>test</u> pass indication otherwise.

- 25. (original) The apparatus according to claim 24, wherein said phase error signal comprises a digital sample.
- 26. (original) The apparatus according to claim 24, wherein said phase error signal comprises an analog sample.
- 27. (original) The apparatus according to claim 24, wherein said threshold is configurable.
- 28. (original) The apparatus according to claim 24, wherein said criteria is configurable.
- 29. (original) The apparatus according to claim 24, wherein said period of time is configurable.
- 30. (original) The apparatus according to claim 24, wherein said threshold is configured to correspond to a particular noise threshold on a modulation noise probability density function.
- 31. (original) The apparatus according to claim 24, wherein lowering said threshold causes the number of exception events to increase for the same criteria and period of time and increasing said threshold causes the number of exception events to decrease for the same criteria and period of time.
- 32. (currently amended) The method according to claim 24, adapted to be implemented in testing software adapted to execute on an embedded microprocessor or digital signal processor.
- 33. (original) The apparatus according to claim 32, wherein said testing software is stored in rewritable memory wherein said testing software is replaced by normal operation software once testing is complete.

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- 34. (currently amended) The apparatus according to claim 24, adapted to be implemented in an Application Specific Integrated Circuit (ASIC).
- 35. (currently amended) The apparatus according to claim 24, adapted to be implemented in a Field Programmable Gate Array (FPGA).
- 36. (new) A method of testing an oscillator in a phase locked loop, said method comprising the steps of:
 - generating a normalized phase error signal from a plurality of phase error samples generated by said phase locked loop; and
 - counting the number of times said normalized phase error signal crosses a threshold within a predefined period of time, wherein the count represents an estimate of the phase modulation noise of said oscillator; and
 - failing said oscillator if said count exceeds a predefined maximum, and passing said oscillator otherwise.
- 37. (new) The method according to claim 36, wherein said maximum corresponds to a modulation quality requirement of a particular standard.